

# Search Notes



Application/Control No.

10/030,519

Examiner

Mark W. Bockelman

Applicant(s)/Patent under Reexamination

LANG ET AL.

Art Unit

3762

## SEARCHED

Class	Subclass	Date	Examiner
607	148,149 115, 153	6-11-05	MB
600	372, 386 393-394		
up to date		2-6-06	MB

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR